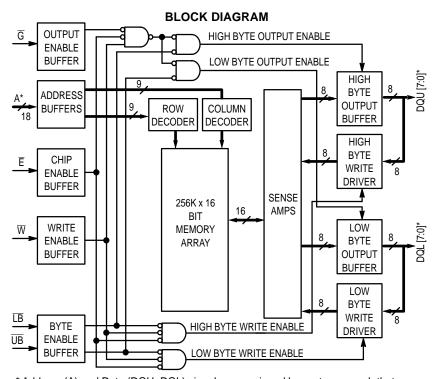
256K x 16 Bit 3.3 V Asynchronous Fast Static RAM

The MCM6343 is a 4,194,304–bit static random access memory organized as 262,144 words of 16 bits. Static design eliminates the need for external clocks or timing strobes.

The MCM6343 is equipped with chip enable (\overline{E}) , write enable (\overline{W}) , and output enable (\overline{G}) pins, allowing for greater system flexibility and eliminating bus contention problems. Separate byte enable controls (\overline{LB}) and (\overline{UB}) allow individual bytes to be written and read. (\overline{LB}) controls the lower bits DQL [7:0], while (\overline{UB}) controls the upper bits DQU [7:0].

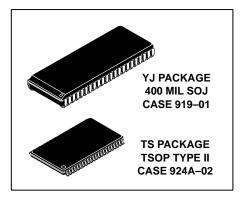
The MCM6343 is available in a 400 mil, 44–lead small–outline SOJ package and a 44–lead TSOP Type II package.

- Single 3.3 V Power Supply
- Fast Access Time: 10/11/12/15 ns
- · Equal Address and Chip Enable Access Time
- All Inputs and Outputs are TTL Compatible
- Data Byte Control
- Fully Static Operation
- Power Operation: 200/195/190/180 mA Maximum, Active AC
- Commercial (0°C to 70°C) and Industrial Temperature (– 40 to 85°C) Options



^{*} Address (A) and Data (DQU, DQL) signals are assigned by customer, such that PCB layout is optimized for a given design.

MCM6343



PIN	I ASSIGN	IMENT
Α [1 ●	44 D A
Α [2	43 A
A 0	3	42 A
A 0	4	41 🛭 🖫
A 0	5	40 D UB
E C	6	39 TB
DQL [7	38 DQU
DQL [8	37 DQU
DQL [9	36 DQU
DQL [10	35 DQU
V _{DD} C	11	34 D V _{SS}
V _{SS} D	12	33 D V _{DD}
DQL [13	32 DQU
DQL [14	31 DQU
DQL [15	30 DQU
DQL [29 DQU
	17	28 D NC
A [18	27 A
A [19	26 A
A [20	25 A
A 0	21	24 D A
A [22	23 A

PIN NAM	ES
A [17:0] E W G UB LB DQL [7:0] DQU [7:0] DV D D D D D D D D D D D D	Chip Enable Write Enable Output Enable Upper Byte Select Lower Byte Select Oata I/O, Low Byte eata I/O, High Byte
V _{DD} + 3. V _{SS} NC	Ground

REV 8 2/2/99



TRUTH TABLE (X = Don't Care)

E	G	W	LB	UB	Mode	V _{DD} Current	DQL [7:0]	DQU [7:0]
Н	Х	Х	Х	Х	Not Selected	Not Selected I _{SB1} , I _{SB2} Hi		High–Z
L	Н	Н	Х	Х	Output Disabled	Output Disabled IDDA High-Z		High–Z
L	Х	Х	Н	Н	Output Disabled I _{DDA} High–Z		High–Z	
L	L	Н	L	Н	Low Byte Read I _{DDA} D _{out}		High–Z	
L	L	Н	Н	L	High Byte Read	IDDA	High-Z	D _{out}
L	L	Н	L	L	Word Read	I _{DDA}	D _{out}	D _{out}
L	Х	L	L	Н	Low Byte Write	I _{DDA}	D _{in}	High–Z
L	Х	L	Н	L	High Byte Write	I _{DDA}	High–Z	D _{in}
L	Х	L	L	L	Word Write	I _{DDA}	D _{in}	D _{in}

ABSOLUTE MAXIMUM RATINGS (See Notes)

Rating		Symbol	Value	Unit
Supply Voltage		V_{DD}	- 0.5 to 4.6	V
Voltage on Any Pin		V _{in}	– 0.5 to V _{DD} + 0.5	V
Output Current per Pin		l _{out}	± 20	mA
Package Power Dissipation	n	PD	TBD	W
Temperature Under Bias	Commercial Industrial	T _{bias}	– 10 to 85 – 45 to 90	°C
Operating Temperature Commercial Industrial		T _A	0 to 70 - 45 to 85	°C
Storage Temperature		T _{stg}	- 55 to 150	°C

NOTES:

- 1. Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded. Functional operation should be restricted to RECOMMENDED OPER-ATING CONDITIONS. Exposure to higher than recommended voltages for extended periods of time could affect device reliability.
- 2. All voltages are referenced to VSS.
- 3. Power dissipation capability will be dependent upon package characteristics and use environment.

This device contains circuitry to protect the inputs against damage due to high static voltages or electric fields; however, it is advised that normal precautions be taken to avoid application of any voltage higher than maximum rated voltages to these high-impedance circuits.

This CMOS memory circuit has been designed to meet the dc and ac specifications shown in the tables, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow of at least 500 linear feet per minute is maintained.

PRODUCT CONFIGURATIONS

			Power	Supply
Part Number	Commercial	Industrial	+ 10%, – 5%	± 10%
MCM6343YJ10B & MCM6343YJ10BR	<i>\\</i>		~	
MCM6343YJ11 & MCM6343YJ11R	<i>\\\\</i>			~
MCM6343YJ12 & MCM6343YJ12R	<i>\\\\</i>			~
MCM6343YJ15 & MCM6343YJ15R	<i>\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\</i>			~
MCM6343TS10B & MCM6343TS10BR	ν		~	
MCM6343TS11 & MCM6343TS11R	ν			~
MCM6343TS12 & MCM6343TS12R	<i>\rightarrow</i>			~
MCM6343TS15 & MCM6343TS15R	<i>\\</i>			~
SCM6343YJ11A & SCM6343YJ11AR		~		~
SCM6343YJ12A & SCM6343YJ12AR		<i>\undersigned</i>		~
SCM6343YJ15A & SCM6343YJ15AR		<i>\undersigned</i>		~
SCM6343TS11A & SCM6343TS11AR		ν		~
SCM6343TS12A & SCM6343TS12AR		ν		~
SCM6343TS15A & SCM6343TS15AR		<i>\ru</i>		~

DC OPERATING CONDITIONS AND CHARACTERISTICS

(V_{DD} = 3.3 V \pm 0.3 V, T_A = 0 to 70°C, V_{DD} = 3.3 V + 0.3 V, - 0.15 V for 10 ns Device) (T_A = - 40 to 85°C for Industrial Temperature Option)

RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Min	Тур	Max	Unit
Power Supply Voltage	V _{DD}	3	3.3	3.6	V
Input High Voltage	VIH	2.2	_	V _{DD} + 0.3**	V
Input Low Voltage	VIL	- 0.5*	_	0.8	V

^{*} V_{II} (min) = -0.5 V dc; V_{II} (min) = -2.0 V ac (pulse width ≤ 20 ns) for $I \leq 20.0$ mA.

DC CHARACTERISTICS

Parameter	Symbol	Min	Max	Unit	
Input Leakage Current (All Inputs, V _{in} = 0 to V _{DD})		l _{lkg(l)}	_	± 1	μΑ
Output Leakage Current ($\overline{E} = V_{IH}$, $V_{Out} = 0$ to V_{DD})		llkg(O)	_	± 1	μΑ
Output Low Voltage	$(I_{OL} = + 4 \text{ mA})$ $(I_{OL} = + 100 \mu\text{A})$	VOL	_	0.4 V _{SS} + 0.2	V
Output High Voltage	$(I_{OH} = -4 \text{ mA})$ $(I_{OH} = -100 \mu\text{A})$	VOH	2.4 V _{DD} – 0.2		V

POWER SUPPLY CURRENTS

Parameter	Symbol	0 to 70°C	– 40 to 85°C	Unit	
AC Active Supply Current (Iout = 0 mA, V _{CC} = Max)	MCM6343–10: t_{AVAV} = 10 ns MCM6343–11: t_{AVAV} = 11 ns MCM6343–12: t_{AVAV} = 12 ns MCM6343–15: t_{AVAV} = 15 ns	ICC	200 195 190 180	260 255 250 240	mA
AC Standby Current (V _{CC} = Max, \overline{E} = V _{IH} , No Other Restrictions on Other Inputs)	MCM6343–10: t_{AVAV} = 10 ns MCM6343–11: t_{AVAV} = 11 ns MCM6343–12: t_{AVAV} = 12 ns MCM6343–15: t_{AVAV} = 15 ns	I _{SB1}	45 40 35 30	55 55 55 50	mA
CMOS Standby Current ($\overline{E} \ge V_{CC} - 0.2 \text{ V}, V_{in} \le (V_{CC} = \text{Max}, f = 0 \text{ MHz})$	I _{SB2}	8	10	mA	

$\textbf{CAPACITANCE} \text{ (f = 1.0 MHz, dV = 3.0 V, } T_{\mbox{\scriptsize A}} = 25^{\circ}\mbox{\scriptsize C}, \mbox{ Periodically Sampled Rather Than 100\% Tested)}$

Parameter	Symbol	Тур	Max	Unit
Address Input Capacitance	C _{in}	_	6	pF
Control Input Capacitance	C _{in}	_	6	pF
Input/Output Capacitance	C _{I/O}	_	8	pF

^{**} V_{IH} (max) = V_{DD} + 0.3 V dc; V_{IH} (max) = V_{DD} + 2.0 V ac (pulse width \leq 20 ns) for I \leq 20.0 mA.

AC OPERATING CONDITIONS AND CHARACTERISTICS

(V_{CC} = 3.3 V \pm 0.3 V, T_A = 0 to 70°C, V_{DD} = 3.3 V + 0.3 V, - 0.15 V for 10 ns Device) (T_A = - 40 to 85°C for Industrial Temperature Option)

Logic Input Timing Measurement Reference Level 1.50 V	Output Timing Reference Level
Logic Input Pulse Levels 0 to 3.0 V	Output Load See Figure 1
Input Rise/Fall Time	

READ CYCLE TIMING (See Notes 1, 2, and 3)

		MCM6	343–10	мсм6	343–11	мсм6	343–12	MCM6	343–15		
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit	Notes
Read Cycle Time	tAVAV	10	_	11	_	12	_	15	_	ns	4
Address Access Time	tAVQV	_	10	_	11	_	12	_	15	ns	
Enable Access Time	t _{ELQV}	_	10	_	11	_	12	_	15	ns	5
Output Enable Access Time	tGLQV	_	4	_	4	_	4	_	5	ns	
Output Hold from Address Change	tAXQX	3	_	3	_	3	_	3	_	ns	
Enable Low to Output Active	tELQX	3	_	3	_	3	_	3	_	ns	6, 7, 8
Output Enable Low to Output Active	tGLQX	0	_	0	_	0	_	0	_	ns	6, 7, 8
Enable High to Output High–Z	tEHQZ	0	5	0	6	0	6	0	7	ns	6, 7, 8
Output Enable High to Output High–Z	tGHQZ	0	4	0	4	0	4	0	5	ns	6, 7, 8
Byte Enable Access Time	t _{BLQV}	_	5	_	6	_	6	_	7	ns	
Byte Enable Low to Output Active	tBLQX	0	_	0	_	0	_	0	_	ns	6, 7, 8
Byte High to Output High–Z	t _{BHQZ}	0	5	0	6	0	6	0	7	ns	6, 7, 8

NOTES:

- 1. W is high for read cycle.
- 2. Product sensitivities to noise require proper grounding and decoupling of power supplies as well as minimization or elimination of bus contention conditions during read and write cycles.
- 3. Device is continuously selected ($\overline{E} \le V_{IL}$, $\overline{G} \le V_{IL}$).
- 4. All read cycle timings are referenced from the last valid address to the first transitioning address.
- 5. Addresses valid prior to or coincident with \overline{E} going low.
- 6. At any given voltage and temperature, t_{EHQZ} max < t_{ELQX} min, and t_{GHQZ} max < t_{GLQX} min, both for a given device and from device to device.
- 7. This parameter is sampled and not 100% tested.
- 8. Transition is measured \pm 200 mV from steady–state voltage.

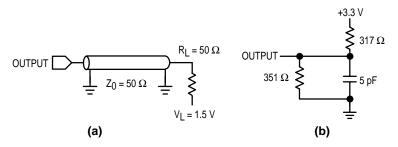


Figure 1. AC Test Loads

TIMING LIMITS

The table of timing values shows either a minimum or a maximum limit for each parameter. Input requirements are specified from the external system point of view. Thus, address setup time is shown as a minimum since the system must supply at least that much time. On the other hand, responses from the memory are specified from the device point of view. Thus, the access time is shown as a maximum since the device never provides data later than that time.

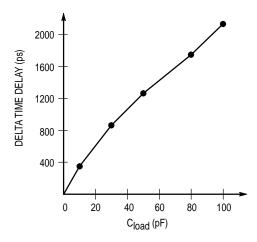
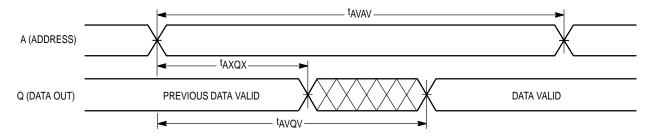
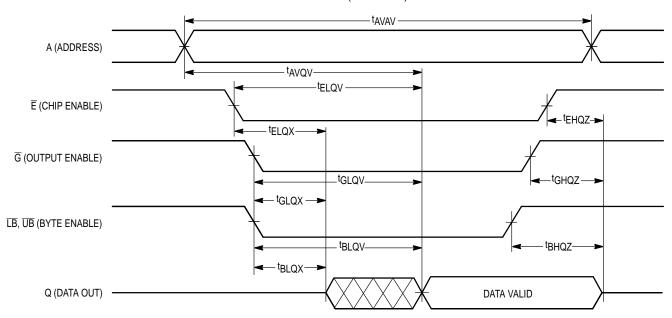


Figure 2. Typical I/O Derating Curve

READ CYCLE 1 (See Note 8)



READ CYCLE 2 (See Note 4)



WRITE CYCLE 1 (W Controlled; See Notes 1, 2, and 3)

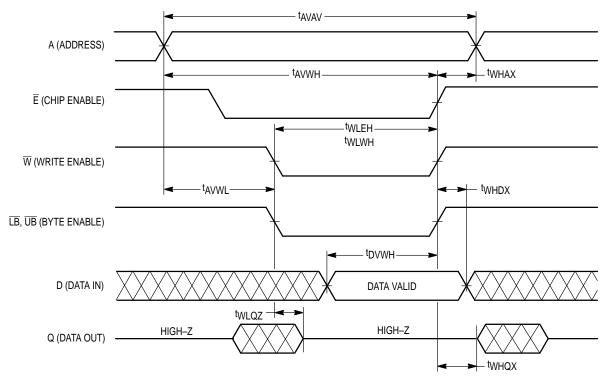
		мсм6	343–10	3-10 MCM6343-11		MCM6343-12		MCM6343-15			
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit	Notes
Write Cycle Time	tAVAV	10	_	11	_	12	_	15	_	ns	4
Address Setup Time	tAVWL	0	_	0	_	0	_	0	_	ns	
Address Valid to End of Write	tAVWH	7	_	8	_	8	_	10	_	ns	
Address Valid to End of Write (G High)	^t AVWH	8	_	9	_	9	_	10	_	ns	
Write Pulse Width	tWLWH tWLEH	9	_	10	_	10	_	12	_	ns	
Write Pulse Width (G High)	tWLWH tWLEH	8	_	9	_	9	_	10	_	ns	
Data Valid to End of Write	tDVWH	5	_	6	_	6	_	7	_	ns	
Data Hold Time	tWHDX	0	_	0	_	0	_	0	_	ns	
Write Low to Data High–Z	tWLQZ	0	5	0	6	0	6	0	7	ns	5, 6, 7
Write High to Output Active	tWHQX	3	_	3	_	3	_	3	_	ns	5, 6, 7
Write Recovery Time	tWHAX	0	_	0	_	0	_	0	_	ns	

NOTES:

- 1. A write occurs during the overlap of $\overline{\mathsf{E}}$ low and $\overline{\mathsf{W}}$ low.
- 2. Product sensitivities to noise require proper grounding and decoupling of power supplies as well as minimization or elimination of bus contention conditions during read and write cycles.
- 3. If \overline{G} goes low coincident with or after \overline{W} goes low, the output will remain in a high–impedance state.
- 4. All write cycle timings are referenced from the last valid address to the first transitioning address.
- 5. This parameter is sampled and not 100% tested.
- 6. Transition is measured \pm 200 mV from steady–state voltage.
- 7. At any given voltage and temperature, tWLQZ max < tWHQX min both for a given device and from device to device.

WRITE CYCLE 1

(W Controlled; See Notes 1, 2, and 3)



WRITE CYCLE 2 (E Controlled; See Notes 1, 2, and 3)

		MCM6	343–10	мсм6	343–11	MCM6	343–12	MCM6	343–15		
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit	Notes
Write Cycle Time	tavav	10	_	11	_	12	_	15	_	ns	4
Address Setup Time	^t AVEL	0	_	0	_	0	_	0	_	ns	
Address Valid to End of Write	^t AVEH	9	_	10	_	10	_	12	_	ns	
Address Valid to End of Write (G High)	^t AVEH	8	_	9	_	9	_	10	_	ns	
Enable to End of Write	tELEH, tELWH	9	_	10	_	10	_	12	_	ns	5, 6
Enable to End of Write (G High)	^t ELEH, ^t ELWH	8	_	9	_	9	_	10	_	ns	5, 6
Data Valid to End of Write	tDVEH	5	_	6	_	6	_	7	_	ns	
Data Hold Time	^t EHDX	0	_	0	_	0	_	0	_	ns	
Write Recovery Time	t _{EHAX}	0	_	0	_	0	_	0	_	ns	

NOTES:

- 1. A write occurs during the overlap of \overline{E} low and \overline{W} low.
- 2. Product sensitivities to noise require proper grounding and decoupling of power supplies as well as minimization or elimination of bus contention conditions during read and write cycles.
- 3. If \overline{G} goes low coincident with or after \overline{W} goes low, the output will remain in a high–impedance state.
- 4. All write cycle timing is referenced from the last valid address to the first transitioning address.
- 5. If \overline{E} goes low coincident with or after \overline{W} goes low, the output will remain in a high–impedance condition.
- 6. If \overline{E} goes high coincident with or before \overline{W} goes high, the output will remain in a high–impedance condition.

WRITE CYCLE 2 (E Controlled; See Notes 1, 2, and 3) - tavav -A (ADDRESS) ^tAVEH ^tEHAX tel en E (CHIP ENABLE) tELWH-W (WRITE ENABLE) LB, UB (BYTE ENABLE) ^tDVEH tehdx D (DATA IN) DATA VALID HIGH-Z Q (DATA OUT) -

WRITE CYCLE 3 (E Controlled; See Notes 1, 2, and 3)

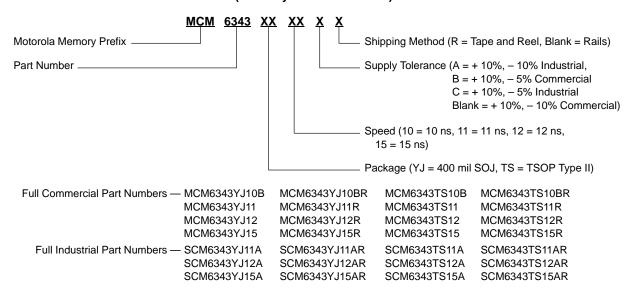
		MCM6	343–10	мсм6	343–11	мсм6	343–12	MCM6	343–15		
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit	Notes
Write Cycle Time	tavav	10	_	11	_	12	_	15	_	ns	4
Address Setup Time	^t AVBL	0	_	0	_	0	_	0	_	ns	
Address Valid to End of Write	^t AVBH	9	_	10	_	10	_	12	_	ns	
Address Valid to End of Write (G High)	^t AVBH	8	_	9	_	9	_	10	_	ns	
Byte Pulse Width	^t BLWH ^t BLEH	9	_	10	_	10	_	12	_	ns	
Byte Pulse Width (G High)	^t BLWH ^t BLEH	8	_	9	_	9	_	10	_	ns	
Data Valid to End of Write	^t DVBH	5	_	6	_	6	_	7	_	ns	
Data Hold Time	^t BHDX	0	_	0	_	0	_	0	_	ns	

NOTES:

- 1. A write occurs during the overlap of \overline{E} low and \overline{W} low.
- 2. Product sensitivities to noise require proper grounding and decoupling of power supplies as well as minimization or elimination of bus contention conditions during read and write cycles.
- 3. If \overline{G} goes low coincident with or after \overline{W} goes low, the output will remain in a high–impedance state.
- 4. All write cycle timings are referenced from the last valid address to the first transitioning address.

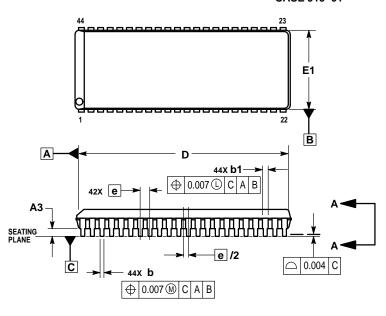
WRITE CYCLE 3 (E Controlled; See Notes 1, 2, and 3) **t**AVAV A (ADDRESS) ^tAVBH E (CHIP ENABLE) **tAVBL** ^tBLEH ^tBLWH LB, UB (BYTE ENABLE) ^tBHDX W (WRITE ENABLE) ^tDVBH D (DATA IN) DATA VALID HIGH-Z HIGH-Z Q (DATA OUT)

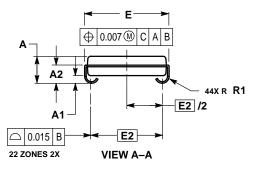
ORDERING INFORMATION (Order by Full Part Number)



PACKAGE DIMENSIONS

YJ PACKAGE 44-LEAD 400 MIL SOJ CASE 919-01





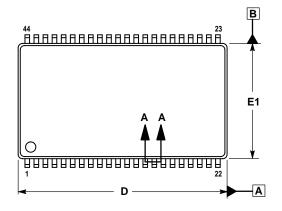
NOTES:

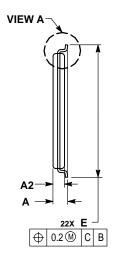
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: INCH.
 DIMENSION D DOES NOT INCLUDE MOLD FLASH,
- 3. DIMENSION D DOES NOT INCLUDE MOLD FLASH, TIE BAR BURRS AND GATE BURRS. MOLD FLASH, TIE BAR BURRS AND GATE BURRS SHALL NOT EXCEED 0.006 PER END. DIMENSION E1 DOES NOT INCLUDE INTERLEAD FLASH. INTERLEAD FLASH SHALL NOT EXCEED 0.010 PER SIDE.
- 4. THE PACKAGE TOP MAY BE SMALLER THAN THE PACKAGE BOTTOM. DIMENSIONS D AND E1 AND, HENCE, DATUMS A AND B, ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY EXCLUSIVE OF MOLD FLASH, IT B BAR BURRS, GATE BURRS AND INTERLEAD FLASH, BUT INCLUDING ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.

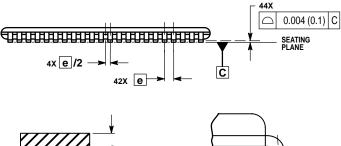
 5. DIMENSION b1 DOES NOT INCLUDE DAMBAR
- DIMENSION 61 DOES NOT INCLUDE DAMBAR PROTRUSION OR INTRUSION. THE DAMBBAR PROTRUSION(S) SHALL NOT CAUSE THE SHOULDER WIDTH TO EXCEED 61 MAX BY MORE THAN 0.005. THE DAMBAR INTRUSION(S) SHALL NOT REDUCE THE SHOULDER WIDTH TO LESS THAN 0.001 BELOW 61 MIN.

	INCHES					
DIM	MIN	MAX				
Α	0.128	0.148				
A1	0.025					
A2	0.082					
A3	0.035	0.045				
b	0.015	0.020				
b1	0.026	0.032				
D	1.120	1.130				
Е	0.435	0.445				
E1	0.395	0.405				
E2	0.370 BSC					
е	0.050 BSC					
R1	0.030 0.040					

TS PACKAGE 44-LEAD **TSOP TYPE II** CASE 924A-02







Α1 СВ 0.2 M SECTION A-A VIEW A ROTATED 90 ° CLOCKWISE

NOTES

- DIMENSIONINS AND TOLERANCING PER ASME
- Y14.5M, 1994. DIMENSIONS IN MILLIMETER
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE MOLD PROTRUSION
- IS 0.15 PER SIDE.

 DIMENSION 5 DOES NOT INCLUDE DAMBAR
 PROTRUSIONS. DAMBAR PROTRUSION SHALL
 NOT CAUSE THE LEAD WIDTH TO EXCEED 0.58.

	MILLIMETERS							
DIM	MIN	MAX						
Α		1.20						
A1	0.05	0.15						
A2	0.95	1.05						
b	0.30	0.45						
С	0.12	0.21						
D	18.28	18.54						
е	0.80	BSC						
Е	11.56	11.96						
E1	10.03	10.29						
L	0.40	0.60						
A	0 °	5°						

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